Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
<u> </u>	8956	amplifier same quadrature	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S S	NO	2005/05/05 07:27
2	8572	I1 and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	N O	2005/05/05 07:27
<u>n</u>	31	I2 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	NO	2005/05/05 09:18
4	8/9	amplifier same (quadrature adj (sens\$3 detect\$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	NO	2005/05/05 09:25
5	645	l4 and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR.	NO	2005/05/05 09:18
77	48	I5 and ((narrow adj bankd) narrow\$1band)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	SO.	NO	2005/05/05 07:37
61	н	10/817090	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	NO	2005/05/05 07:47

111	7	I5 and impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	SO.	N O	2005/05/05 08:05
1.25	4584	(324/158.1.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S,	N O	2005/05/05 08:51
176	21	I25 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	N O	2005/05/05 08:51
727	397	(324/239.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	N O	2005/05/05 08:51
178	9	I27 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	N O	2005/05/05 09:17
	592	vector adj modulator	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	NO O	2005/05/05 09:17
ر ا	574	29 and @ad<"20040402"	USPAT; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	NO	2005/05/05 09:18

[31	E.	I30 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S S	NO NO	2005/05/05 10:07
[33	9	l30 and (quadrature adj (sens\$3 detect\$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	NO	2005/05/05 10:08
134	m	l30 and amplifier same (quadrature adj (sens\$3 detect\$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	N O	2005/05/05 10:09
S1	43	(324/610.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	N O	2005/05/05 07:25
23	236	(324/609,602,600.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S S	N O	2005/05/05 08:42
SS	2	jp-10038936-\$.did.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S S	N O	2005/05/04 08:35
<b>S</b> 4	317	(324/525.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	N O	2005/05/04 09:07

SS	82	(324/123C.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	SO.	NO	2005/05/04 09:07
98	176	(324/436,442.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S S	NO	2005/05/04 09:08
22	356	(324/135,139,236.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	æ	NO	2005/05/04 11:33
88	829	(impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment).ti.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	NO	2005/05/04 10:37
65	708	S8 and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	NO	2005/05/04 10:41
S10	ហ	S9 and automatic\$5 adj balanc\$5 adj (bridge link channel bus network connect\$5 line communicat\$5 interface)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	NO	2005/05/04 10:58
S11	4396	(impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	SO.	NO	2005/05/04 15:55

S12	4166	S11 and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT;	80	NO	2005/05/04 10:41
513	ω	S12 and automatic\$5 adj balanc\$5 adj (bridge link channel bus network connect\$5 line communicat\$5 interface)	LEN LDB US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM TDB	S S	NO	2005/05/04 11:06
S14	12	S12 and four\$2 adj (voltage current signal input stimul\$7) adj2 (source suppl\$5)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	& S	N O	2005/05/04 11:16
<b>S15</b>	539	S12 and ((sine adj (voltage current signal input stimul\$7 wave)) sine\$1voltage sine\$1current sine\$1signal sine\$1input sine\$1stimul\$7 sine\$1wave)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	N O	2005/05/04 12:39
516	12	S14 and four\$2 adj (voltage current signal input stimul\$7) adj2 (source suppl\$5)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S S	N O	2005/05/04 11:18
S17	0	S16 and ((cosine adj (voltage current signal input stimul\$7 wave)) cosine\$1voltage cosine\$1current cosine\$1signal cosine\$1input cosine\$1stimul\$7 cosine\$1wave)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S S	N O	2005/05/04 12:48
518	49	S15 and ((cosine adj (voltage current signal input stimul\$7 wave)) cosine\$1voltage cosine\$1current cosine\$1signal cosine\$1input cosine\$1stimul\$7 cosine\$1wave)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	Se .	NO	2005/05/04 12:45

S19	984	(324/649,650,691,713.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S S	N O	2005/05/04 11:53
820	824	(327/100.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	N O	2005/05/04 11:54
521	1499	(379/30,377,394,398.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	N O	2005/05/04 11:54
S22	246	(600/399,400,442.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR.	N O	2005/05/04 11:54
523	1038	(600/506,547.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	N O	2005/05/04 11:55
S24	1028	(702/65,117.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	N O	2005/05/04 15:51
525	87	S19 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	NO	2005/05/04 11:55

2005/05/04 12:45	2005/05/04 12:48	2005/05/04 12:46	2005/05/04 11:57	2005/05/04 15:53	2005/05/04 12:48	2005/05/04 12:47
NO NO	N O	N O	N O	N O	N O	NO O
%	N N	g	g.	g S	S S	R
US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	USPAT; USPAT; EPO; JPO; DERWENT; IBM_TDB	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB
1 S20 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	calculat\$3 \$2valuat\$3 examin\$5 test\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	2 S22 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	<ul> <li>S23 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3</li> <li>calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3</li> <li>identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))</li> </ul>	S24 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	525 and ((sine adj (voltage current signal input stimul\$7 wave)) sine\$1voltage sine\$1current sine\$1signal sine\$1input sine\$1stimul\$7 sine\$1wave)	4 S27 and ((sine adj (voltage current signal input stimul\$7 wave)) sine\$1voltage sine\$1current sine\$1signal sine\$1input sine\$1stimul\$7 sine\$1wave)
H	22	iN .	232	58	21	٧
S26	527	S28	829	230	S31	S32

US-PGPUB; OR ON 2005/05/04 12:47 USPAT; EPO; JPO; DERWENT; IBM_TDB	US-PGPUB; OR ON 2005/05/04 12:46 USPAT; EPO; JPO; DERWENT; IBM_TDB	US-PGPUB; OR ON 2005/05/04 12:44 USPAT; EPO; JPO; DERWENT; IBM_TDB	US-PGPUB; OR 0N 2005/05/04 12:47 USPAT; EPO; JPO; DERWENT; IBM_TDB	US-PGPUB; OR 0N 2005/05/04 12:49 USPAT; EPO; JPO; DERWENT; IBM_TDB	US-PGPUB; OR ON 2005/05/04 12:48 USPAT;	EPO; JPO; DERWENT; IBM_TDB
S30 and ((sine adj (voltage current signal input stimul\$7 wave)) sine\$1voltage sine\$1current sine\$1signal sine\$1input sine\$1stimul\$7 sine\$1wave)	S31 and ((cosine adj (voltage current signal input stimul\$7 wave)) cosine\$1voltage cosine\$1current cosine\$1signal cosine\$1input cosine\$1stimul\$7 cosine\$1wave)	S32 and ((cosine adj (voltage current signal input stimul\$7 wave)) cosine\$1voltage cosine\$1current cosine\$1signal cosine\$1input cosine\$1stimul\$7 cosine\$1wave)	S33 and ((cosine adj (voltage current signal input stimul\$7 wave)) cosine\$1voltage cosine\$1current cosine\$1signal cosine\$1input cosine\$1stimul\$7 cosine\$1wave)	S29 and ((sine adj (voltage current signal input stimul\$7 wave)) sine\$1voltage sine\$1current sine\$1signal sine\$1input sine\$1stimul\$7 sine\$1wave)	S37 and ((cosine adj (voltage current signal input stimul\$7 wave)) cosine\$1voltage cosine\$1current cosine\$1signal cosine\$1input	cosine\$1stimul\$/ cosine\$1wave)
01	<u>и</u>	0	<del></del>	£	<del></del>	
233	S34	235	536	537	238	

OR 2005/05/04 15:52	OR 2005/05/04 16:07	OR 2005/05/05 07:26	OR 2005/05/04 16:08	OR 2005/05/04 16:08	OR 2005/05/04 15:56	OR 2005/05/04 16:06
USPAT; USPAT; EPO; JPO; DERWENT; IBM_TDB	USPAT; USPAT; EPO; JPO; DERWENT; IBM_TDB	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB
(702/189-191.ccls.) and @ad<"20040402"	S39 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3,\$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	S40 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	S39 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7))	S40 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7))	impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7)	S45 and @ad<"20040402"
1003	4	Ŋ	σ	14	18121	17086
540	241	S42	543	S44	545	S46

S47	206	S46 and ((process\$5 conver\$5 modulat\$5) near3 (voltage current signal input stimul\$7 wave)) same quadrature	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	NO	2005/05/04 16:06
248	<b>-</b>	S47 and ((narrow adj bankd) narrow\$1band) adj2 amplif\$5	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	NO	2005/05/04 16:06
S49	o.	S47 and ((narrow adj bankd) narrow\$1band)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	NO	2005/05/05 07:37
S50	38	S46 and ((process\$5 conver\$5 modulat\$5) near3 (voltage current signal input stimul\$7 wave)) same quadrature same filter	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S S	N O	2005/05/04 16:09
S51	491	((narrow adj bankd) narrow\$1band) adj2 amplif\$5	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	SO.	N O	2005/05/04 16:06
S52	439	S51 and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	S.	N O	2005/05/04 16:06
S53	17	S52 and ((process\$5 conver\$5 modulat\$5) near3 (voltage current signal input stimul\$7 wave)) same quadrature same filter	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	NO	2005/05/04 16:09